



## Description

The SI4559ADY uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

## General Features

$V_{DS} = 60V$   $I_D = 6A$

$R_{DS(ON)} < 48m\Omega$  @  $V_{GS}=10V$

$V_{DS} = -60V$   $I_D = -5A$

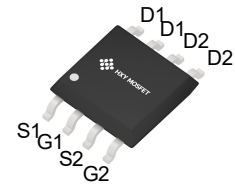
$R_{DS(ON)} < 85 m\Omega$  @  $V_{GS}=-10V$

## Application

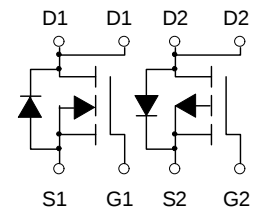
Wireless charging

Boost driver

Brushless motor



SOP-8  
(SOIC-8)



N-Channel and P-Channel

## Ordering Information

| Product ID | Pack          | Brand      | Qty(PCS) |
|------------|---------------|------------|----------|
| SI4559ADY  | SOP-8(SOIC-8) | HXY MOSFET | 3000     |

## Absolute Maximum Ratings ( $T_C=25^{\circ}C$ unless otherwise noted)

| Symbol                  | Parameter                                             | Rating     |            | Units         |
|-------------------------|-------------------------------------------------------|------------|------------|---------------|
|                         |                                                       | N-Channel  | P-Channel  |               |
| $V_{DS}$                | Drain-Source Voltage                                  | 60         | -60        | V             |
| $V_{GS}$                | Gate-Source Voltage                                   | $\pm 20$   | $\pm 20$   | V             |
| $I_{D@T_A=25^{\circ}C}$ | Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup> | 6.0        | -5.0       | A             |
| $I_{D@T_A=70^{\circ}C}$ | Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup> | 4.0        | -3.5       | A             |
| IDM                     | Pulsed Drain Current <sup>2</sup>                     | 11         | -8.5       | A             |
| EAS                     | Single Pulse Avalanche Energy <sup>3</sup>            | 22.5       | 35.3       | mJ            |
| IAS                     | Avalanche Current                                     | 22.6       | -26.6      | A             |
| $P_{D@T_A=25^{\circ}C}$ | Total Power Dissipation <sup>4</sup>                  | 2.5        | 2.5        | W             |
| TSTG                    | Storage Temperature Range                             | -55 to 150 | -55 to 150 | $^{\circ}C$   |
| $T_J$                   | Operating Junction Temperature Range                  | -55 to 150 | -55 to 150 | $^{\circ}C$   |
| $R_{\theta JA}$         | Thermal Resistance Junction-Ambient <sup>1</sup>      | 85         |            | $^{\circ}C/W$ |
| $R_{\theta JC}$         | Thermal Resistance Junction-Case <sup>1</sup>         | 62.5       |            | $^{\circ}C/W$ |



**N-Channel Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , unless otherwise noted)**

| Symbol                                                 | Parameter                                                 | Test Condition                                                                          | Min. | Typ. | Max. | Units |
|--------------------------------------------------------|-----------------------------------------------------------|-----------------------------------------------------------------------------------------|------|------|------|-------|
| Off Characteristic                                     |                                                           |                                                                                         |      |      |      |       |
| V <sub>(BR)DSS</sub>                                   | Drain-Source Breakdown Voltage                            | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA                                              | 60   | -    | -    | V     |
| I <sub>DSS</sub>                                       | Zero Gate Voltage Drain Current                           | V <sub>DS</sub> =60V, V <sub>GS</sub> = 0V,                                             | -    | -    | 1.0  | μA    |
| I <sub>GSS</sub>                                       | Gate to Body Leakage Current                              | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V                                             | -    | -    | ±100 | nA    |
| On Characteristics                                     |                                                           |                                                                                         |      |      |      |       |
| V <sub>GS(th)</sub>                                    | Gate Threshold Voltage                                    | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                | 1.0  | 1.6  | 2.5  | V     |
| R <sub>DS(on)</sub>                                    | Static Drain-Source on-Resistance<br><small>note3</small> | V <sub>GS</sub> =10V, I <sub>D</sub> =5A                                                | -    | 40   | 48   | mΩ    |
|                                                        |                                                           | V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A                                               | -    | 48   | 60   |       |
| Dynamic Characteristics                                |                                                           |                                                                                         |      |      |      |       |
| C <sub>iss</sub>                                       | Input Capacitance                                         | V <sub>DS</sub> =25V, V <sub>GS</sub> =0V,<br>f=1.0MHz                                  | -    | 1148 | -    | pF    |
| C <sub>oss</sub>                                       | Output Capacitance                                        |                                                                                         | -    | 58.5 | -    | pF    |
| C <sub>rss</sub>                                       | Reverse Transfer Capacitance                              |                                                                                         | -    | 49.4 | -    | pF    |
| Q <sub>g</sub>                                         | Total Gate Charge                                         | V <sub>DS</sub> =30V, I <sub>D</sub> =2.5A,<br>V <sub>GS</sub> =10V                     | -    | 20.3 | -    | nC    |
| Q <sub>gs</sub>                                        | Gate-Source Charge                                        |                                                                                         | -    | 3.7  | -    | nC    |
| Q <sub>gd</sub>                                        | Gate-Drain(“Miller”) Charge                               |                                                                                         | -    | 5.3  | -    | nC    |
| Switching Characteristics                              |                                                           |                                                                                         |      |      |      |       |
| t <sub>d(on)</sub>                                     | Turn-on Delay Time                                        | V <sub>DS</sub> =30V, I <sub>D</sub> =5A,<br>R <sub>G</sub> =1.8Ω, V <sub>GS</sub> =10V | -    | 7.6  | -    | ns    |
| t <sub>r</sub>                                         | Turn-on Rise Time                                         |                                                                                         | -    | 20   | -    | ns    |
| t <sub>d(off)</sub>                                    | Turn-off Delay Time                                       |                                                                                         | -    | 15   | -    | ns    |
| t <sub>f</sub>                                         | Turn-off Fall Time                                        |                                                                                         | -    | 24   | -    | ns    |
| Drain-Source Diode Characteristics and Maximum Ratings |                                                           |                                                                                         |      |      |      |       |
| I <sub>S</sub>                                         | Maximum Continuous Drain to Source Diode Forward Current  |                                                                                         | -    | -    | 6    | A     |
| I <sub>SM</sub>                                        | Maximum Pulsed Drain to Source Diode Forward Current      |                                                                                         | -    | -    | 20   | A     |
| V <sub>SD</sub>                                        | Drain to Source Diode Forward Voltage                     | V <sub>GS</sub> =0V, I <sub>S</sub> =5A                                                 | -    | -    | 1.2  | V     |
| t <sub>rr</sub>                                        | Body Diode Reverse Recovery Time                          | I <sub>F</sub> =5A, dI/dt=100A/μs                                                       | -    | 29   | -    | ns    |
| Q <sub>rr</sub>                                        | Body Diode Reverse Recovery Charge                        |                                                                                         | -    | 43   | -    | nC    |

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. EAS condition :  $T_J=25^{\circ}\text{C}, V_{DD}=30V, V_G=10V, L=0.5mH, R_g=25\Omega, I_{AS}=8.7A$

3. Pulse Test: Pulse Width $\leq 300\mu s$ , Duty Cycle $\leq 0.5\%$



**P-Channel Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  , unless otherwise noted)**

| Symbol       | Parameter                                      | Conditions                                                     | Min. | Typ. | Max.      | Unit      |
|--------------|------------------------------------------------|----------------------------------------------------------------|------|------|-----------|-----------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage                 | $V_{GS}=0V$ , $I_D=-250\mu A$                                  | -60  | ---  | ---       | V         |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance <sup>2</sup> | $V_{GS}=-10V$ , $I_D=-3.5A$                                    | ---  | 70   | 100       | $m\Omega$ |
|              |                                                | $V_{GS}=-4.5V$ , $I_D=-3.1A$                                   | ---  | 100  | 115       |           |
| $V_{GS(th)}$ | Gate Threshold Voltage                         | $V_{GS}=V_{DS}$ , $I_D=-250\mu A$                              | -1.0 | ---  | -2.5      | V         |
| $I_{DSS}$    | Drain-Source Leakage Current                   | $V_{DS}=-48V$ , $V_{GS}=0V$ , $T_J=25^{\circ}\text{C}$         | ---  | ---  | 1         | $\mu A$   |
|              |                                                | $V_{DS}=-48V$ , $V_{GS}=0V$ , $T_J=55^{\circ}\text{C}$         | ---  | ---  | 5         |           |
| $I_{GSS}$    | Gate-Source Leakage Current                    | $V_{GS}=\pm 20V$ , $V_{DS}=0V$                                 | ---  | ---  | $\pm 100$ | nA        |
| $g_{fs}$     | Forward Transconductance                       | $V_{DS}=-5V$ , $I_D=-3A$                                       | ---  | 8.5  | ---       | S         |
| $Q_g$        | Total Gate Charge (-4.5V)                      | $V_{DS}=-48V$ , $V_{GS}=-4.5V$ , $I_D=-3A$                     | ---  | 12.1 | ---       | nC        |
| $Q_{gs}$     | Gate-Source Charge                             |                                                                | ---  | 2.2  | ---       |           |
| $Q_{gd}$     | Gate-Drain Charge                              |                                                                | ---  | 6.3  | ---       |           |
| $T_{d(on)}$  | Turn-On Delay Time                             | $V_{DD}=-15V$ , $V_{GS}=-10V$ , $R_G=3.3\Omega$ ,<br>$I_D=-1A$ | ---  | 9.2  | ---       | ns        |
| $T_r$        | Rise Time                                      |                                                                | ---  | 20.1 | ---       |           |
| $T_{d(off)}$ | Turn-Off Delay Time                            |                                                                | ---  | 46.7 | ---       |           |
| $T_f$        | Fall Time                                      |                                                                | ---  | 9.4  | ---       |           |
| $C_{iss}$    | Input Capacitance                              | $V_{DS}=-15V$ , $V_{GS}=0V$ , $f=1\text{MHz}$                  | ---  | 1137 | ---       | pF        |
| $C_{oss}$    | Output Capacitance                             |                                                                | ---  | 76   | ---       |           |
| $C_{rss}$    | Reverse Transfer Capacitance                   |                                                                | ---  | 50   | ---       |           |
| $I_S$        | Continuous Source Current <sup>1,5</sup>       | $V_G=V_D=0V$ , Force Current                                   | ---  | ---  | -6.0      | A         |
| $V_{SD}$     | Diode Forward Voltage <sup>2</sup>             | $V_{GS}=0V$ , $I_S=-1A$ , $T_J=25^{\circ}\text{C}$             | ---  | ---  | -1.2      | V         |

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is  $V_{DD}=-25V$  ,  $V_{GS}=-10V$  ,  $L=0.1\text{mH}$  ,  $I_{AS}=-24A$
- 4.The power dissipation is limited by  $150^{\circ}\text{C}$  junction temperature
- 5.The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.



## N-Channel Typical Characteristics

Figure1: Output Characteristics

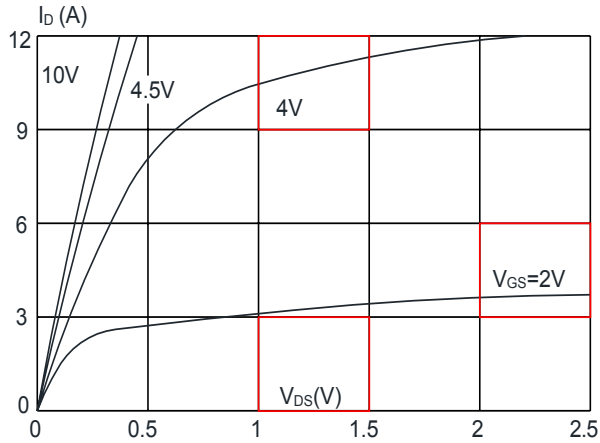


Figure 2: Typical Transfer Characteristics

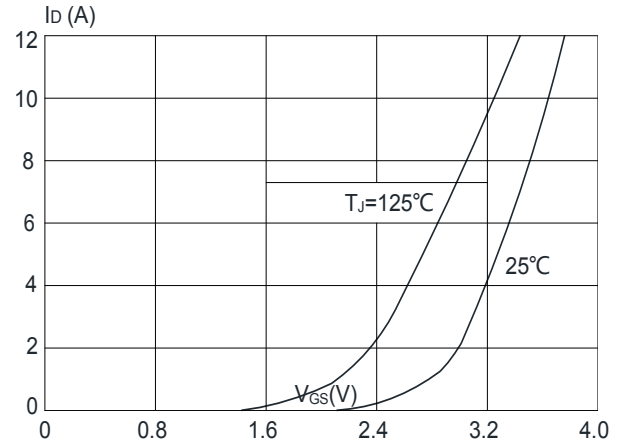


Figure 3: On-resistance vs. Drain Current

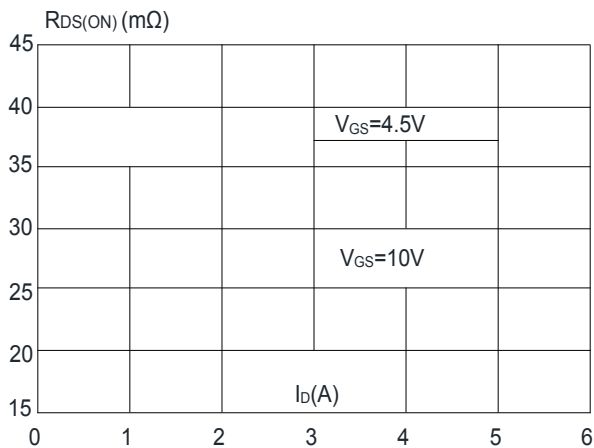


Figure 4: Body Diode Characteristics

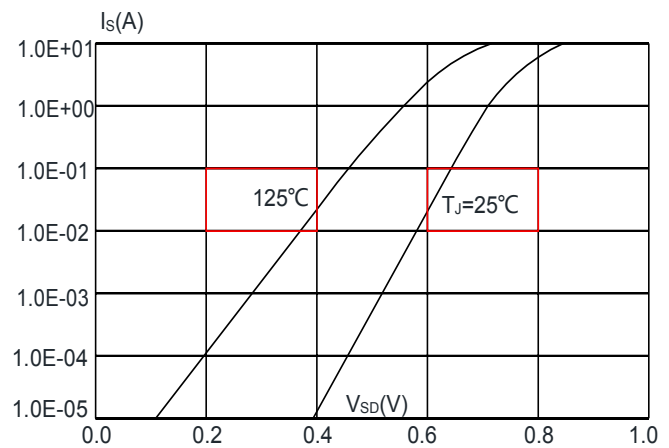


Figure 5: Gate Charge Characteristics

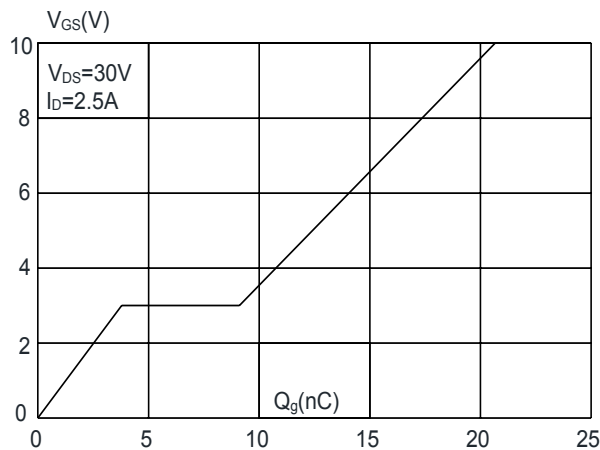
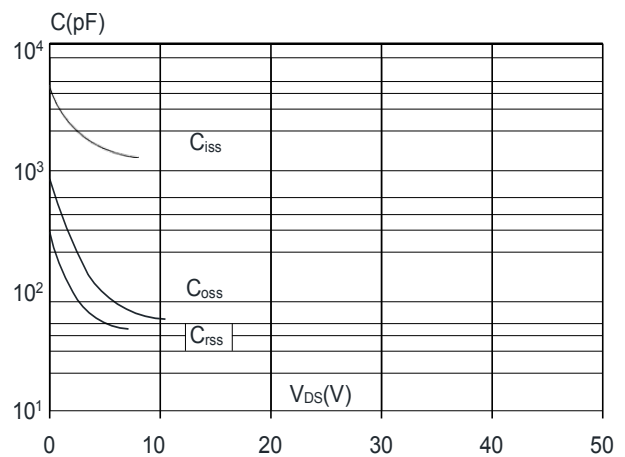
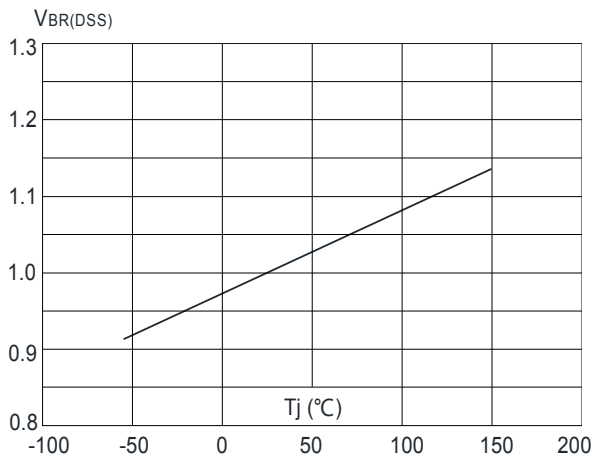


Figure 6: Capacitance Characteristics

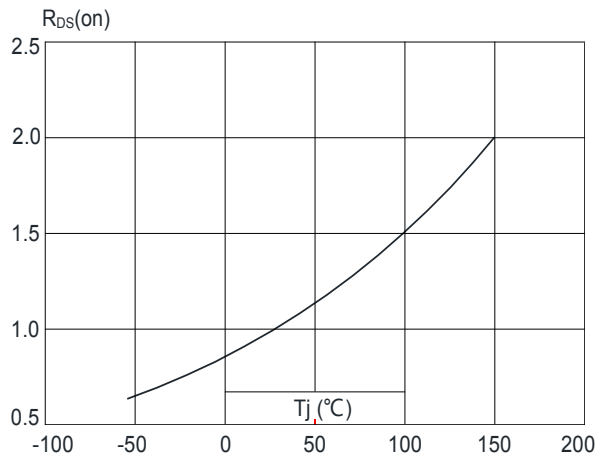




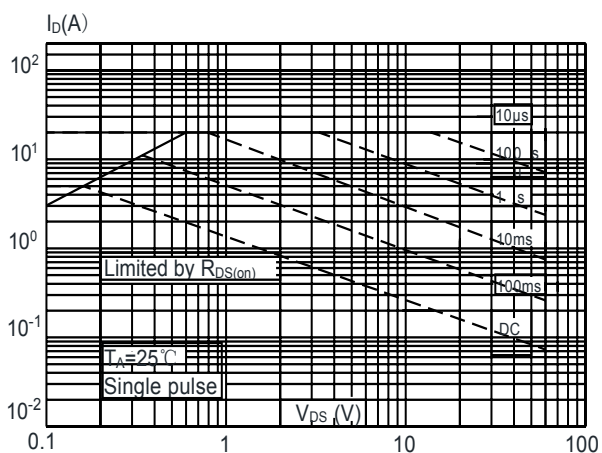
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



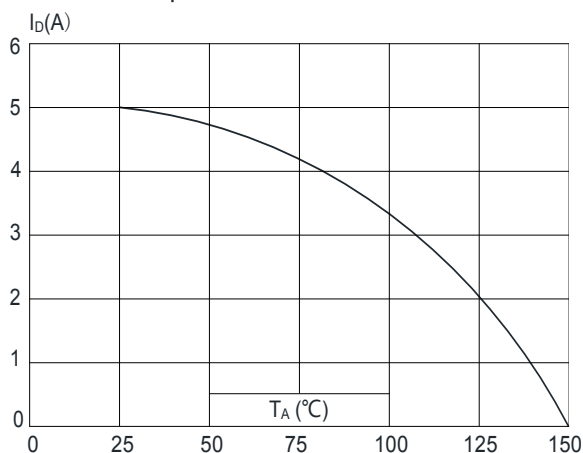
**Figure 8:** Normalized on Resistance vs. Junction Temperature



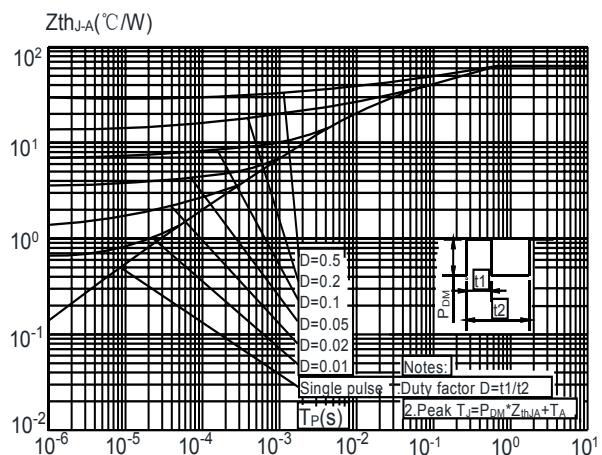
**Figure 9:** Maximum Safe Operating Area



**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature

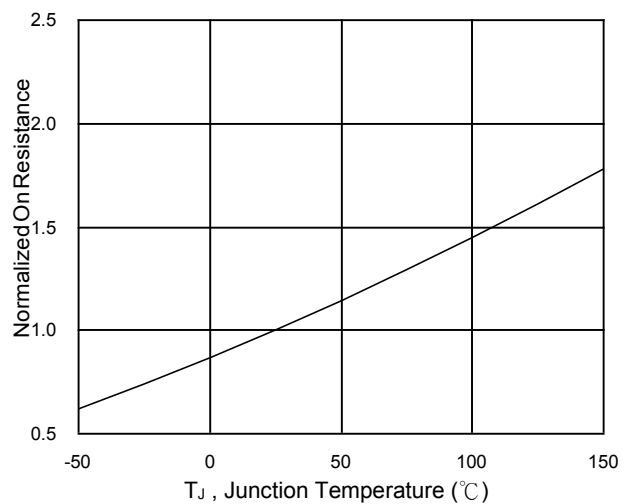
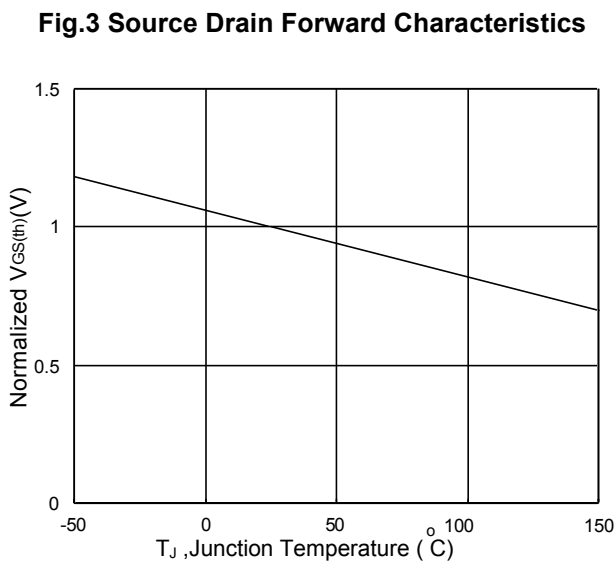
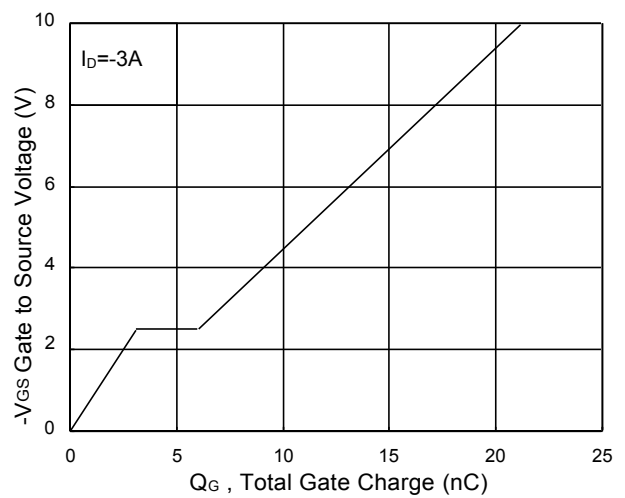
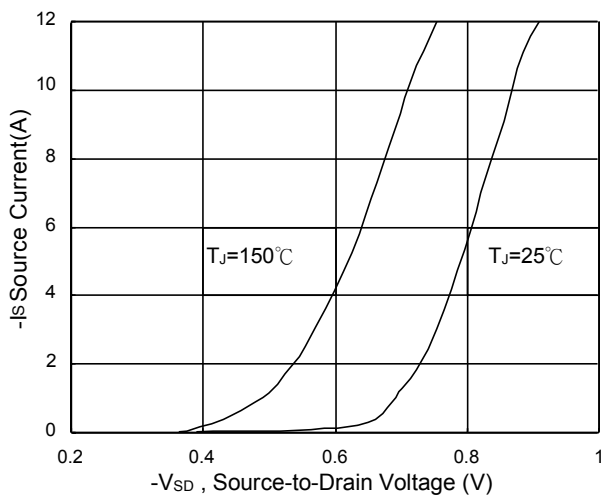
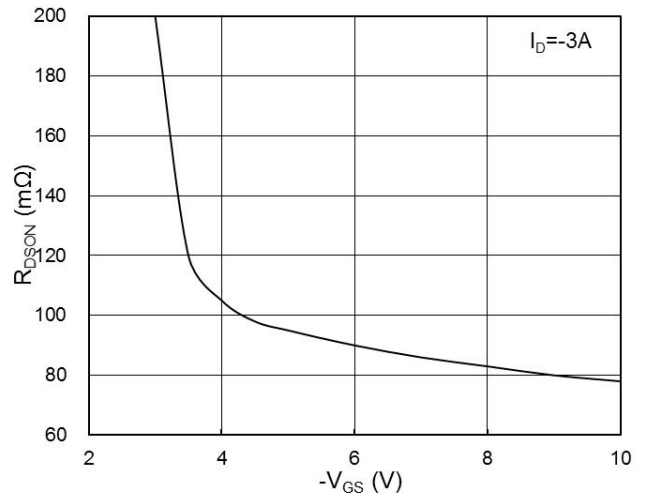
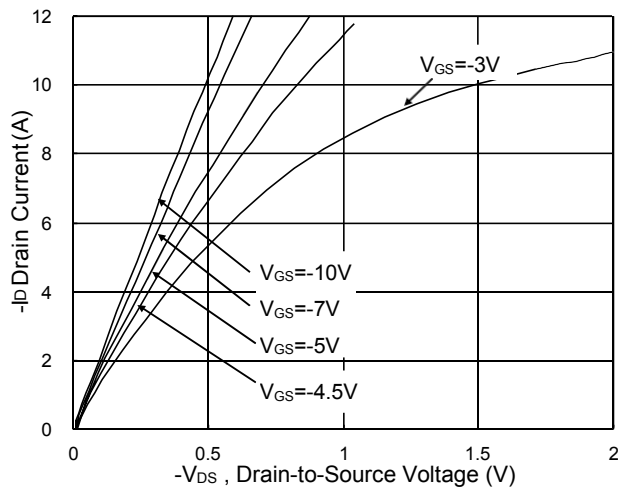


**Figure.11:** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient





## P-Channel Typical Characteristics



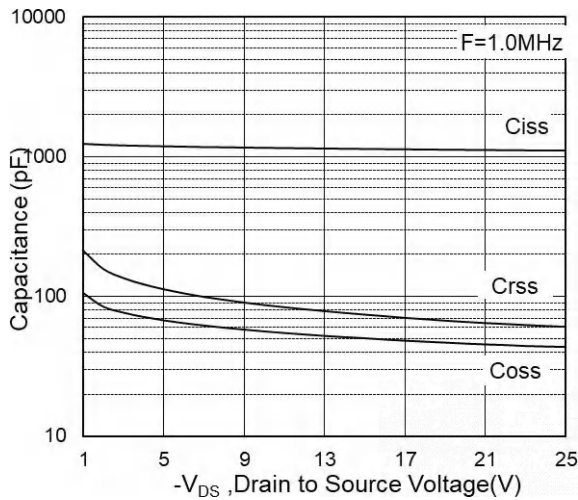


Fig.7 Capacitance

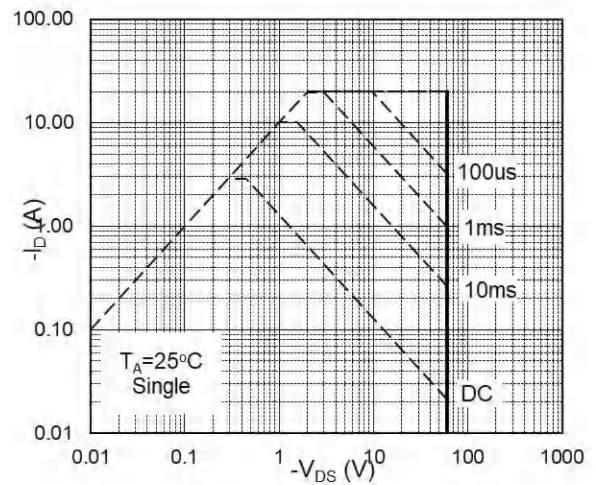


Fig.8 Safe Operating Area

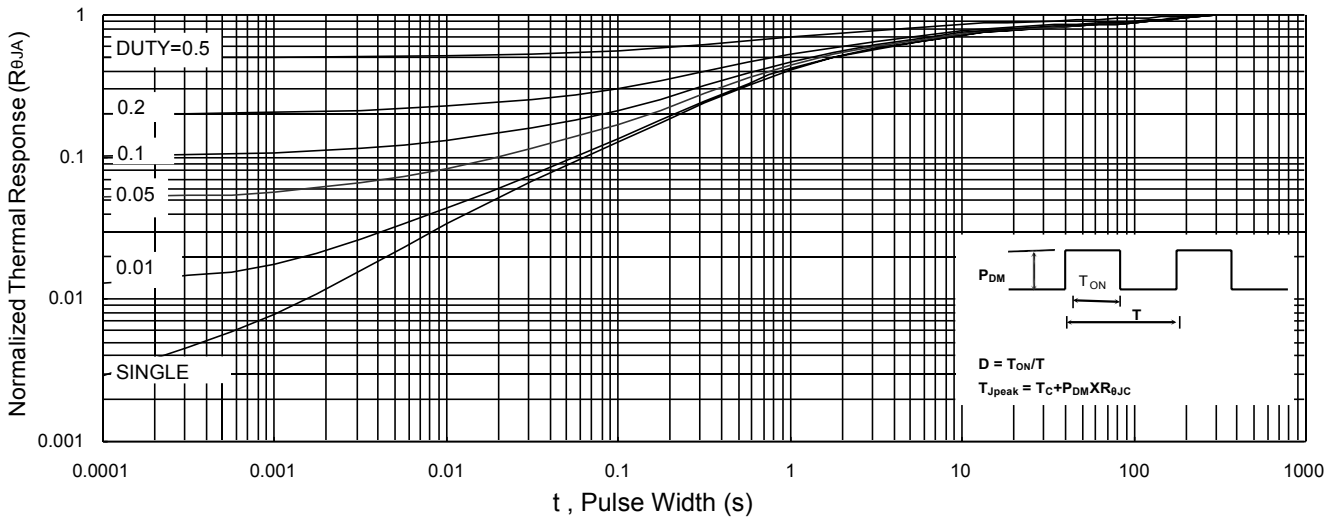


Fig.9 Normalized Maximum Transient Thermal Impedance

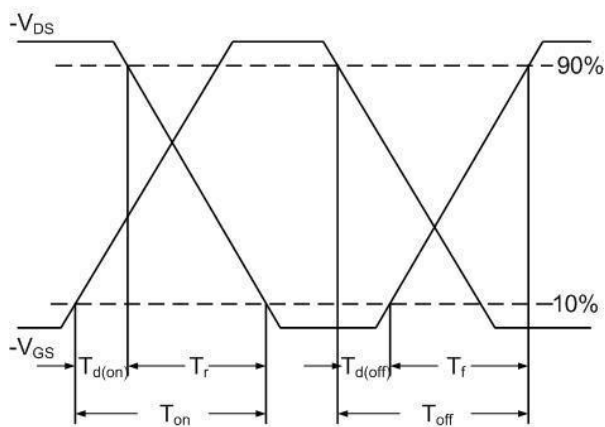


Fig.10 Switching Time Waveform

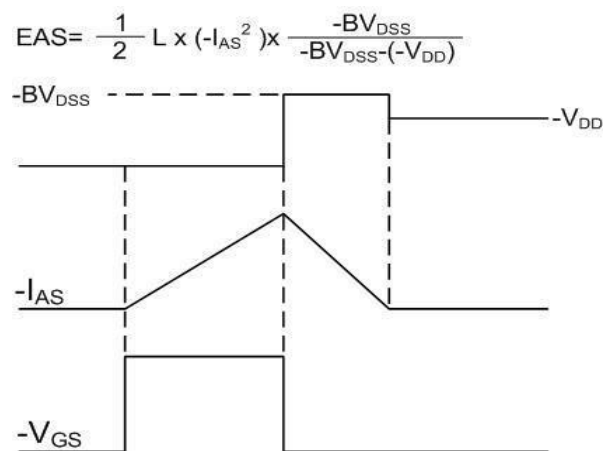
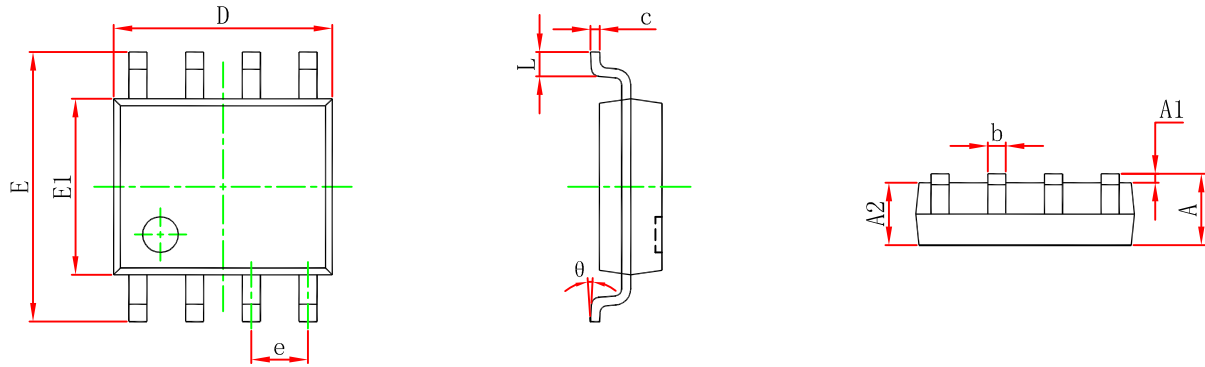


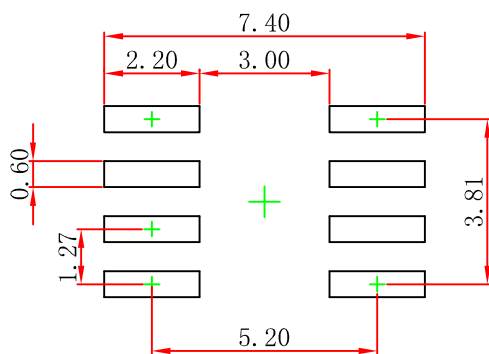
Fig.11 Unclamped Inductive Waveform



## SOP-8(SOIC-8) Package Outline Dimensions



| Symbol | Dimensions In Millimeters |       | Dimensions In Inches |       |
|--------|---------------------------|-------|----------------------|-------|
|        | Min                       | Max   | Min                  | Max   |
| A      | 1.350                     | 1.750 | 0.053                | 0.069 |
| A1     | 0.100                     | 0.250 | 0.004                | 0.010 |
| A2     | 1.350                     | 1.550 | 0.053                | 0.061 |
| b      | 0.330                     | 0.510 | 0.013                | 0.020 |
| c      | 0.170                     | 0.250 | 0.007                | 0.010 |
| D      | 4.800                     | 5.000 | 0.189                | 0.197 |
| e      | 1.270 (BSC)               |       | 0.050 (BSC)          |       |
| E      | 5.800                     | 6.200 | 0.228                | 0.244 |
| E1     | 3.800                     | 4.000 | 0.150                | 0.157 |
| L      | 0.400                     | 1.270 | 0.016                | 0.050 |
| θ      | 0°                        | 8°    | 0°                   | 8°    |



Note:  
1. Controlling dimension; in millimeters.  
2. General tolerance:  $\pm 0.05\text{mm}$ .  
3. The pad layout is for reference purposes only.



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